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## Special Issue on Reliability and Validity and Its Applications

## Call for Papers

Reliability and validity are important aspects of selecting a survey instrument. Reliability refers to the extent that the instrument yields the same results over multiple trials. Validity refers to the extent that the instrument measures what it was designed to measure. In research, there are three ways to approach validity and they include content validity, construct validity, and criterion-related validity. The goal of this special issue is to provide a platform for scientists and academicians all over the world to promote, share, and discuss various new issues and developments in the area of **Reliability and Validity and Its Applications**.

In this special issue, we intend to invite front-line researchers and authors to submit original research and review articles on exploring **Reliability and Validity and Its Applications**. In this special issue, potential topics include, but are not limited to:

- Test-retest reliability
- Internal consistency
- Interrater reliability
- Face validity
- Content validity
- Criterion validity
- Discriminant validity
- Testing and assessment
- Applications of reliability & validity in psychology
- Applications of reliability & validity in medical
- Applications of reliability & validity in engineering

Authors should read over the journal's <u>For Authors</u> carefully before submission. Prospective authors should submit an electronic copy of their complete manuscript through the journal's <u>Paper Submission System</u>.

Please kindly notice that the "**Special Issue**" under your manuscript title is supposed to be specified and the research field "**Special Issue** - *Reliability and Validity and Its Applications*" should be chosen during your submission.

According to the following timetable:

Submission Deadline	October 20th, 2024
Publication Date	December 2024

## **Guest Editor:**



## **Open Journal of Statistics**

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For further questions or inquiries Please contact Editorial Assistant at ojs@scirp.org